

(12) INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

(19) World Intellectual Property Organization
International Bureau



(43) International Publication Date
23 October 2003 (23.10.2003)

PCT

(10) International Publication Number
WO 03/087777 A1

(51) International Patent Classification⁷: **G01N 1/24**
(21) International Application Number: **PCT/IL03/00041**
(22) International Filing Date: 15 January 2003 (15.01.2003)
(25) Filing Language: English
(26) Publication Language: English
(30) Priority Data:
60/372,805 17 April 2002 (17.04.2002) US
(63) Related by continuation (CON) or continuation-in-part (CIP) to earlier application:
US 60/372,805 (CIP)
Filed on 17 April 2002 (17.04.2002)
(71) Applicant (for all designated States except US): **TRACE-TRACK TECHNOLOGY LTD.** [IL/IL]; Yigal Alon Street 94, 67891 Tel-Aviv (IL).

(81) Designated States (*national*): AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NO, NZ, OM, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, TJ, TM, TN, TR, TT, TZ, UA, UG, US, UZ, VC, VN, YU, ZA, ZM, ZW.

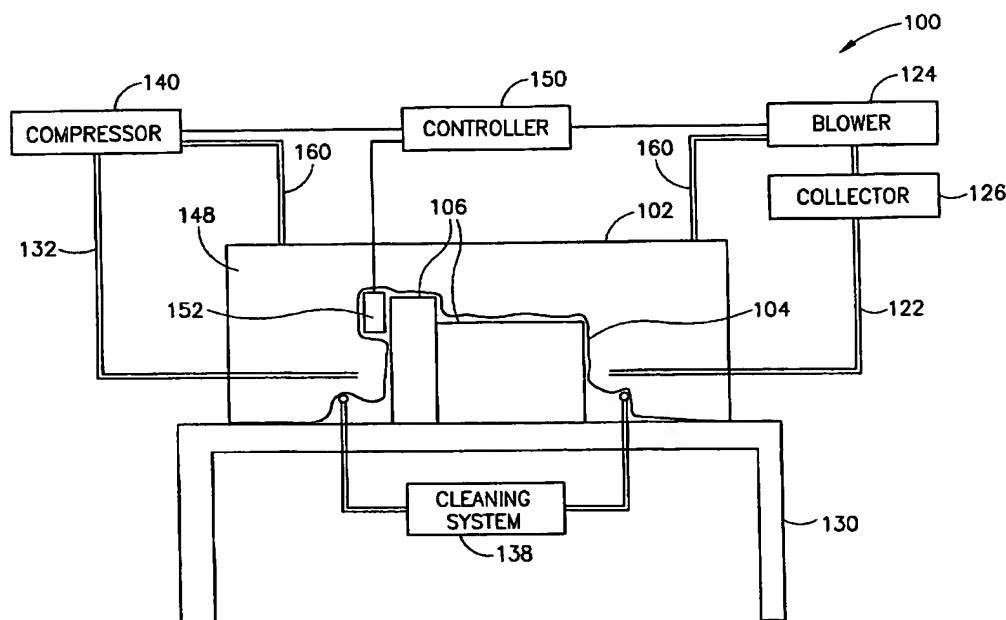
(84) Designated States (*regional*): ARIPO patent (GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IT, LU, MC, NL, PT, SE, SI, SK, TR), OAPI patent (BF, BJ, CF, CG, CI, CM, GA, GN, GQ, GW, ML, MR, NE, SN, TD, TG).

Published:

— with international search report

For two-letter codes and other abbreviations, refer to the "Guidance Notes on Codes and Abbreviations" appearing at the beginning of each regular issue of the PCT Gazette.

(54) Title: **CONTAMINANT SCANNING SYSTEM**



(57) Abstract: A method of collecting vapors from an inspected item (106). The method includes providing an item (106) for inspection, forming a chamber (136) around the inspected item (106), with a volume determined responsive to the inspected item (106), applying one or more vapor release measures to the dimensions of the inspected item (106), removing gas samples from the formed chamber (136), and analyzing the removed gas samples for traces of one or more chemicals.

WO 03/087777 A1

CONTAMINANT SCANNING SYSTEM**RELATED APPLICATION**

This application claims the benefit under 119 (e) of US provisional patent application
5 60/372,805, filed April 17, 2002, the disclosure of which is incorporated herein by reference.

FIELD OF THE INVENTION

The present invention relates to systems for identifying the presence of chemical materials and in particular to screening systems.

BACKGROUND OF THE INVENTION

10 One method for scanning luggage for illegal materials, such as explosives and drugs, is collecting vapors and small particles (referred to collectively herein as vapors) from the luggage and passing the vapors to a detection system (also known as a trace analyzer) which determines whether the vapors include traces of specific materials.

One type of collection apparatus includes hand held machines, such as described in U.S.
15 patent 4,909,090 to McGown et al., U.S. patent 5,092,220 to Rounbehler, and U.S. patent 5,123,274 to Carroll et al., the disclosures of which documents is incorporated herein by reference. These machines are directed by a human holding the machine to suck air from the surface of inspected luggage. The machines may heat the surface of the luggage and/or direct jets of air at the luggage in order to aid in dislodging vapors from the luggage. These hand held
20 collection apparatus suffer from high cost of operators who need to pass the machine over the luggage and from low accuracy due to collection of only a small portion of the air surrounding the luggage.

Instead of bringing the collection apparatus to the inspected luggage, some systems suggest the use of a swab or brush to remove samples from the luggage. Particles collected by
25 the swab or brush are then provided to the detection system.

Other collection systems include chambers into which the luggage is inserted, such as described in U.S. patents 5,942,699 and 6,324,927 to Ornath et al., 4,580,440 to Reid et al., 5,162,652 to Cohen et al., 3,942,357 to Jenkins et al., 3,998,101 to Bradshaw et al., the disclosures of which documents is incorporated herein by reference. The luggage is preferably
30 sealed in the chamber and various methods are used to dislodge vapors from the luggage. The air in the chamber is then passed to an inspection system. The volume of air in these chambers is generally too large such that some contaminants having low dilution rates are not detected.

Other collection systems are directed to checking humans and therefore are not sealed. The operation of these systems is similar to that described above, except that there is no airtight

seal. Such systems are described, for example, in U.S. patent 4,909,089 to Achter et al., and 5,345,809 to Corrigan et al., the disclosures of which documents is incorporated herein by reference.

SUMMARY OF THE INVENTION

5 An aspect of some embodiments of the present invention relates to a vapor collection system including an inspection chamber having an adjustable size. Inspected items are placed in the chamber and before causing the release of vapors from the inspected items, the size of the chamber is adjusted to minimize the volume of the chamber.

10 In some embodiments of the invention, at least some of the walls of the chamber are formed of a flexible mantle, for example of plastic. A pressure difference is optionally formed between the inside and outside of the chamber, such that the flexible mantle conforms to the shape of the inspected items. The pressure difference is optionally substantially constant and relatively small. In some embodiments of the invention, the pressure difference is applied by sustaining a pressure lower than the atmospheric pressure in the chamber. Alternatively or
15 additionally, an external chamber, at a higher pressure, enclosing the inspection chamber is used. Optionally, the walls of the chamber are closely spaced from the inspected items but not touching the items, over at least a portion of the surface of the inspected items. The spacing of the walls from the inspected items prevents the walls from interfering with collecting the vapors.

20 An aspect of some embodiments of the present invention relates to an automatic position adjustment system, which is used to automatically adjust the position of one or more units of the system which interacts with the inspected items. The one or more units which interact with the inspected items optionally include one or more of suction nozzles, air blowing nozzles, heaters and radiation sources.

25 In some embodiments of the invention, the one or more units whose positions are adjusted are mounted on walls of a chamber in which the inspected items are inserted and their position is adjusted by changing the positions of the walls of the chamber, for example to conform to the outer contours of the inspected items. Alternatively or additionally, one or more of the units is mounted on a carrier separate from the walls of the chamber. Optionally, the
30 units whose positions are adjusted are located in a hermetically sealed chamber. The adjustment of the positions of the units is optionally performed although the chamber is sealed, in order to limit the amount of air or other gas in the chamber that needs to be processed by the trace analyzer.

An aspect of some embodiments of the present invention relates to a vapor collection system, including an inspection chamber and an external chamber at least partially surrounding the inspection chamber. The external chamber optionally has a controlled and variable gas pressure, such that the relative gas pressure between the inspection chamber and the external chamber is controllable, for example kept constant. In some embodiments of the invention, during a vapor release stage, the pressure within the inspection chamber is varied, while the relative pressure between the inspection chamber and the external chamber is substantially constant.

An aspect of some embodiments of the present invention relates to a method of collecting vapor samples, in which a collection unit is placed in an inspected item without a human holding the collection unit. Optionally, the inspected item is closed with the collection unit inside the inspected item.

Optionally, the collection unit applies one or more vapor release inducement measures, such as vibration, air jets and/or radiation. In some embodiments of the invention, the collection unit is flexible and is inflated and/or deflated in order to induce vibrations in the inspected item.

In some embodiments of the invention, the collection unit is included entirely in the inspected item and is not connected to external apparatus, through tubes, wires or a wireless link. Alternatively, the collection unit is connected to wirelessly to an external apparatus. Further alternatively, the collection unit is connected through wires or tubes to an external collection unit. For example, the collection unit optionally does not include a trace analyzer or collection chamber, but rather passes collected vapors to a collection chamber external to the inspected item.

In some embodiments of the invention, the collection unit placed in the inspected item is used in conjunction with a vapor collection system which collects vapors from the outer surface of the inspected item. Alternatively or additionally, the collection unit placed in the inspected item is used in conjunction with a vapor release inducement system, which applies vapor release enhancement measures to the inspected item, from outside of the inspected item.

An aspect of some embodiments of the present invention relates to a method of collecting vapors in which cooperation is achieved between apparatus within inspected items and apparatus outside of the inspected items. Optionally, vapor release measures are applied from at least one of an internal and external vapor unit and gas samples are collected by the

BEST AVAILABLE COPY

other of the internal and external vapor units. Cooperation of an internal and an external unit generally provide more efficient collection of vapors from the inspected item.

An aspect of some embodiments of the present invention relates to a method of collecting vapor samples, in which a vapor release inducement unit, which does not collect vapors, is placed in an inspected item and induces vapor release while vapors are collected from the inspected item by a separate collection unit. Optionally, the separate collection unit is located outside of the inspected item. Alternatively or additionally, a separate collection unit is inserted into the inspected item adjacent the vapor release unit or remote therefrom.

An aspect of some embodiments of the invention relates to a vapor release inducement unit which vibrates within an inspected item. The vapor release inducement unit may optionally also collect vapors from the inspected item. Optionally, the vapor release inducement unit comprises a flexible casing which is inflated and/or deflated to induce vapor release.

There is therefore provided in accordance with an exemplary embodiment of the invention, a method of collecting vapors from an inspected item, comprising providing an item for inspection, forming a chamber around the inspected item, with a volume determined responsive to the inspected item, applying one or more vapor release measures to the dimensions of the inspected item, removing gas samples from the formed chamber, and analyzing the removed gas samples for traces of one or more chemicals.

Optionally, providing the item for inspection comprises placing the item in a chamber and wherein forming the chamber around the inspected item comprises reducing the volume of the chamber. Optionally, reducing the volume of the chamber comprises pumping air out of the chamber. Optionally, pumping air out of the chamber comprises pumping using a same blower as used for removing gas samples from the inspected items. Optionally, the chamber is at least partially defined by a flexible mantle, which conforms to the dimensions of the inspected items when the air is pumped out of the chamber. Optionally, after the air is pumped out of the chamber the mantle is spaced from the objects by legs protruding from the mantle.

Optionally, reducing the volume of the chamber comprises moving one or more walls of the chamber toward the inspected item. Optionally, forming the chamber comprises forming an air tight chamber and/or a chamber having an pressure lower than its surrounding. Optionally, providing the item for inspection comprises placing the inspected item on a flexible mantle and wherein forming a chamber around the inspected item comprises connecting portions of the mantle on different sides of the inspected item. Optionally, forming the chamber around the

inspected item comprises connecting a plurality of walls around the provided item, so as to form the inspected chamber.

Optionally, forming the chamber around the inspected item comprises rapping a single mantle around the inspected item. Optionally, forming the chamber comprises forming a chamber having a volume of 20% or less larger than the volume of the inspected item. Optionally, applying one or more vapor release measures to the inspected item comprises applying one or more gas jets to the inspected item. Optionally, applying the one or more gas jets and removing the gas samples are controlled together so that the pressure of the chamber follows a desired course.

Optionally, the chamber formed around the inspected item is located within an external chamber and wherein the control of the applied gas jets and the removing of the samples is performed such that relative pressure between the chamber formed around the inspected item and the external chamber is substantially constant. Optionally, forming the chamber around the inspected item comprises forming the chamber such that at least one wall of the chamber, carrying an orifice applying a gas jet at the inspected item is within a predetermined distance range from the inspected item. Optionally, applying one or more air jets at the inspected item comprises applying hot air jets at the item. Optionally, applying one or more air jets at the inspected item comprises applying intermittent air jets at the item. Optionally, removing gas samples from the formed chamber comprises exhausting through one or more orifices in at least one wall of the chamber. Optionally, applying one or more vapor release measures to the inspected item comprises vibrating the inspected item and/or applying shock waves. Optionally, removing gas samples comprises removing air. Optionally, removing gas samples comprises removing a gas other than air.

There is further provided in accordance with an exemplary embodiment of the invention, a vapor collection system, comprising a base on which inspected items are placed, one or more wall portions adapted to form a chamber of a variable volume around items placed on the base, at least one tube adapted to remove gas samples from the chamber, and an analysis unit adapted to determine whether the gas samples include one or more chemicals.

Optionally, the base and one or more wall portions comprise a single flexible mantle piece. Optionally, the one or more wall portions comprise one or more flexible mantle pieces. Optionally, at least a portion of the at least one tube adapted to remove gas samples is coupled to the one or more flexible mantle pieces. Optionally, at least a portion of the at least one tube adapted to remove gas samples is embedded within the one or more flexible mantle pieces.

Optionally, the system includes one or more legs protruding from the one or more flexible mantle pieces, which prevent the flexible mantle from closely contacting the inspected items. Optionally, the base participates in defining the chamber with the one or more walls. Optionally, the base does not participate in defining the chamber with the one or more walls.

5 Optionally, the at least one tubes are embedded within the one or more walls. Optionally, the system includes a blower adapted to exhaust gas out of the chamber so as to adjust the volume of the chamber. Optionally, the blower is adapted to remove gas samples from the chamber through the at least one tube. Optionally, the system includes a compressor adapted to inject gas into the chamber. Optionally, the system includes a controller adapted to
10 control the compressor and the blower such that during a sample collection period of the system, the relative gas pressure between the chamber and the environment around the chamber is substantially constant, while the blower provides gas samples from the chamber to the analysis unit.

15 There is further provided in accordance with an exemplary embodiment of the invention, a vapor collection system, comprising one or more wall portions adapted to define a chamber for inspected items, at least one vapor collection aiding unit, and a mount having an adjustable position, on which the at least one vapor collection aiding unit is mounted.

20 Optionally, the at least one vapor collection aiding unit comprises a suction nozzle and/or a unit for inducing vapor release. Optionally, the unit for inducing vapor release comprises a gas blowing nozzle and/or a heater. Optionally, the mount is one or more of the wall portions. Optionally, the mount is separate from the wall portions. Optionally, the position of the mount is adjusted by adjusting the air pressure in the chamber.

25 There is further provided in accordance with an exemplary embodiment of the invention, a method of collecting vapors from an inspected item, comprising placing a collection head inside the inspected item, the collection head not being held by a human operator, removing gas samples from the inspected item through the collection head, and analyzing the removed gas samples to determine if they include one or more chemicals.

30 Optionally, placing the collection head in the inspected item comprises placing a collection head not connected through tubes to an external system or placing a collection head connected through tubes to an external system. Optionally, the method includes closing the inspected item with the collection head in the inspected item. Optionally, the method includes applying one or more vapor release measures to the inspected item substantially concurrently with removing the gas samples. Optionally, applying one or more vapor release measures to the

inspected item comprises applying the one or more release measures from the collection head. Optionally, applying one or more vapor release measures to the inspected item comprises applying the one or more release measures from a unit within the inspected item, separate from the collection head. Optionally, applying one or more vapor release measures to the inspected
5 item comprises applying the one or more release measures from apparatus external to the inspected item. Optionally, applying one or more vapor release measures to the inspected item comprises directing air jets at the inspected item.

Optionally, applying one or more vapor release measures to the inspected item comprises vibrating the collection head in order to vibrate the inspected item. Optionally,
10 applying one or more vapor release measures to the inspected item comprises inflating and deflating a flexible container of the collection head in order to vibrate the inspected item. Optionally, the method includes collecting gas samples from the inspected item by apparatus external to the inspected item, substantially concurrently with collecting the gas samples through the collection head.

15 There is further provided in accordance with an exemplary embodiment of the invention, a method of collecting vapors from an inspected item, comprising placing an internal vapor unit inside the inspected item, placing an external vapor unit outside of the inspected item, applying a vapor release means at the inspected item from a first one of the external and internal vapor units, and removing gas samples from the inspected item through a second one
20 of the external and internal vapor units. Optionally, the first one of the vapor units comprises the external unit. Optionally, gas samples are not collected from outside the inspected item. Optionally, the first one of the vapor units comprises the internal unit. Optionally, gas samples are not collected from within the inspected item. Optionally, the method includes additionally applying vapor release means from the second of the external and internal vapor units.

25 Optionally, the method includes additionally removing gas samples from the first of the external and internal vapor units. Optionally, placing the external vapor unit outside of the inspected item comprises placing the inspected item inside a chamber of the external vapor unit. Alternatively or additionally, placing the external vapor unit outside of the inspected item comprises forming a chamber of the external vapor unit around the inspected item.

30 Optionally, the internal vapor unit is connected through gas pipes to the external unit. Optionally, the external and internal vapor units are commonly controlled by a single controller. Alternatively, the external and internal vapor units are not commonly controlled during their operation. Optionally, applying vapor release means comprises directing a gas jet

at the inspected item. Optionally, directing a gas jet at the inspected item comprises directing a jet of purified air and/or a pulsed jet of gas.

There is further provided in accordance with an exemplary embodiment of the invention, a method of collecting vapors from an inspected item, comprising inserting a vapor release inducing object into the inspected item, vibrating the vapor release inducing object, and collecting gas samples from the inspected object. Optionally, vibrating the vapor release inducing object comprises inflating and deflating a flexible encasement of the vapor release inducing object. Optionally, vibrating the vapor release inducing object comprises operating a vibrating motor within the vapor release inducing object. Optionally, collecting gas samples comprises collecting from within the inspected item and/or from outside of the inspected item.

BRIEF DESCRIPTION OF FIGURES

Particular non-limiting embodiments of the invention will be described with reference to the following description of embodiments in conjunction with the figures. Identical structures, elements or parts which appear in more than one figure are preferably labeled with a same or similar number in all the figures in which they appear, in which:

Figs. 1A and 1B are schematic illustrations of a vapor inspection system, in two different operation states, in accordance with an exemplary embodiment of the invention;

Fig. 2 is a cross-section view of a portion of a mantle of a vapor inspection system, in accordance with an exemplary embodiment of the invention;

Fig. 3 is a flowchart of acts performed during an inspection session, in accordance with an exemplary embodiment of the invention;

Figs. 4A-4C schematically illustrate mantle structures, in accordance with exemplary embodiments of the invention;

Fig. 5 is a schematic illustration of an inspection system, in accordance with an exemplary embodiment of the invention;

Fig. 6 is a schematic illustration of a collection head for vapors, in accordance with an exemplary embodiment of the invention; and

Fig. 7 is a schematic illustration of a self contained vapor collection unit, in accordance with an exemplary embodiment of the invention.

DETAILED DESCRIPTION OF EXEMPLARY EMBODIMENTS

Figs. 1A and 1B are schematic illustrations of a vapor inspection system 100, in accordance with an exemplary embodiment of the invention. Vapor inspection system 100 optionally includes an external enclosure 102 and a flexible mantle 104 serving as an internal

enclosure. In operation, inspected items 106 are inserted into an inspection chamber 136, enclosed by mantle 104, as shown in Fig. 1A. A blower 124 optionally sucks the air out of the inspection chamber 136, through air pipes 122, such that mantle 104 closely fits around inspected items 106, as shown in Fig. 1B. Thereafter, vapor releasing methods are applied to inspected items 106 in order to release vapors from the items, if such vapors are in and/or on inspected items 106. Intermittently, concurrently and/or after the vapor releasing methods are applied, blower 124 optionally sucks air out of the inspection chamber 136 and the sucked air is passed to a collector 126, which accumulates vapors and/or solids for inspection. A trace analyzer 127 analyzes the collected vapors to determine whether they include chemicals that are being searched for.

In some embodiments of the invention, collector 126 comprises a paper filter and/or a scrubber type collector. Alternatively or additionally, any other collection apparatus is used. Trace analyzer 127 is of any type known in the art, for example, as described in U.S. patent 5,345,809 to Corrigan, et al., the disclosure of which patent is incorporated herein by reference. Trace analyzer 127 optionally operates automatically after a inspection session of system 100 and/or at least partially during the inspection session. Optionally, a user interface displays the names of chemicals which were identified. In some embodiments of the invention, an alarm is operated automatically when at least a predetermined vapor amount of a searched substance is identified. In some embodiments of the invention, trace analyzer 127 is activated after each inspection session of system 100. Alternatively, trace analyzer 127 is activated after a predetermined number of inspection sessions and/or when it is determined to have collected at least a predetermined amount of vapors. Operating trace analyzer 127 for a plurality of inspection sessions reduces the costs of operating trace analyzer 127, at the expense of a less accurate indication of the item in which item the chemicals are contained.

Alternatively to operating automatically, trace analyzer 127 may be activated manually by a human operator. For example, the human operator may determine the frequency of operation of trace analyzer 127 according to a suspiciousness level of the inspected items. Alternatively to trace analyzer 127 being connected to collector 126, collector 126 is removed from system 100 after one or more inspection sessions and is placed in a trace analyzer 127 for analysis. Further alternatively or additionally, a plurality of different trace analyzers, optionally searching for different chemicals, are used. Further alternatively or additionally, system 100 does not include a collector and the sucked gas from chamber 136 is provided directly to analyzer 127.

In some embodiments of the invention, a compressor 140 pumps air into inspection chamber 136, for example through air pipes 132, while blower 124 sucks out air for vapor inspection, in order to keep the pressure within inspection chamber 136 constant. Compressor 140 may be implemented together with blower 124 in the same apparatus or may be implemented in separate apparatus. Optionally, the air pressure within inspection chamber 136 is set such that mantle 104 does not touch and/or crush inspected items 106, while keeping the air volume within inspection chamber 136 minimal. In some embodiments of the invention, the volume of chamber 136 is not more than 20%, 10% or even 5% above the volume of inspected items 106. Alternatively or additionally, the empty volume of chamber 136 is not greater than a predetermined air volume, for example not more than 1-2 liters. Keeping the air volume at a minimal level prevents dilution of vapors extracted from the inspected items, dilution which may make the identification of illegal materials more difficult.

Fig. 1A further illustrates a table 130 on which inspected items 106 are placed. In some embodiments of the invention, table 130 may be vibrated in order to induce vapor release, as described, for example, in the above mentioned U.S. patents 5,942,699 and 3,942,357. Alternatively to table 130, any other base may be used for placement of inspected items 106. In some embodiments of the invention, a portion of a conveyor belt is used as a base. Inspected items may be mounted along the entire conveyor belt, while chamber 136 is formed over a portion of the conveyor belt. Optionally, before operation, mantle 104 is lifted, and a group of one or more inspected items is allowed to enter beneath the mantle. Mantle 104 is then lowered and optionally attached to the base to minimize or prevent escape of air. System 100 is then activated as described above. Thereafter, mantle 104 is lifted and the conveyor belt is moved to change the inspected items 106 beneath the mantle. In some embodiments of the invention, mantle 104 is replaced after each inspection or every predetermined number of items, for example for cleaning.

The conveyor belt may have a circular track such that items not removed from the conveyor belt repeatedly enter the inspection chamber or the conveyor belt may have a beginning point at which items are loaded and an end point where inspected items are unloaded. Alternatively or additionally, the conveyor belt moves in a first direction for loading items and in the opposite direction for unloading the items and the same point is used for loading and unloading items.

In some embodiments of the invention, the portions of the conveyor belt on which inspected items 106 are placed are elevated relative to the remaining portions of the conveyor

belt. The elevated portion is optionally of a predetermined shape in which a bottom portion of mantle 104 fits. In some embodiments of the invention, a bottom portion of mantle 104 is rigid and fits onto the elevated portion in a sealed manner.

5 The conveyor belt and/or table 130 may be impermeable to gases, such that a separate mantle base is not required. Alternatively or additionally, mantle 104 and/or a separate mantle piece may surround the inspected item from below. Optionally, in this alternative, table 130, the conveyor belt and/or any other base on which the inspected items are placed is perforated or otherwise allows air passage, so that air jets may be directed at the items and/or samples may be collected from the inspected items from below. In an exemplary embodiment of the
10 invention, air jets are directed at the inspected items from many directions in order to maximize the surface area from which samples are collected. In an exemplary embodiment of the invention, the conveyor belt comprises a plurality of cylinders which allow air to pass between the cylinders. Alternatively or additionally, the conveyor belt or table 130 comprises a net structure on which inspected items are placed.

15 Alternatively to placing inspected items 106 on a table, conveyor belt or other surface, inspected items 106 may be hung from above. For example, a crane may lift the inspected items and hold them while a chamber is formed around the items.

In some embodiments of the invention, system 100 includes a cleaning system 138 which cleans mantle 104, periodically. The cleaning may be performed before and/or after each
20 inspection, hourly daily and/or at any other required times. Optionally, the cleaning is performed by injecting a liquid detergent toward mantle 104 and pumping out the liquid. Compressor 140 and/or blower 124 may be used thereafter to dry the mantle.

Alternatively or additionally, cleaning may be performed by injecting a liquid detergent, solvent and/or aerosol (optionally heated) through air pipes 132 and sucking the injected
25 material out through pipes 122. Thus, in addition to cleaning mantle 104, the pipes are also cleaned. The cleaning process is optionally completed by injecting dry hot air through the system pipes.

External enclosure 102 optionally defines a sealed pressure chamber 148 having a controlled air pressure. Optionally, the air pressure in chamber 148 is larger than in chamber
30 136 so that mantle 148 is pushed close to inspected items 106. External enclosure 102 may comprise a rigid material or a flexible material as suitable. The air pressure of pressure chamber 148 is optionally held during operation at a desired value relative to the pressure of inspection chamber 136, so that mantle 104 does not change its orientation during operation of

system 100. Optionally, the pressure difference between inspection chamber 136 and its surroundings is small and substantially constant, throughout an inspection session. In some embodiments of the invention, the air pressure within pressure chamber 148 is substantially equal to the atmospheric pressure, at the beginning of the vapor release stage of an inspection session. Alternatively, a higher or lower pressure is used. In some embodiments of the invention, external enclosure 102 is not included in system 100 and the external air pressure is atmospheric.

In some embodiments of the invention, tubes 160 lead from blower 124 and/or compressor 140 so as to control the air pressure within pressure chamber 148. Alternatively or additionally, a separate blower and/or compressor are used for pressure chamber 148. Further alternatively or additionally, tubes 132 and/or 122 and/or portions thereof are used to lead air into and/or out of pressure chamber 148.

Optionally, a controller 150 manages the operation of blower 124 and compressor 140, so as to control the relative air pressure between inspection chamber 136 and pressure chamber 148. An air pressure sensor 152 optionally provides pressure readings to controller 150 which accordingly adjusts the air flow into and out of inspection chamber 136. Alternatively or additionally, one or more other sensors are used and/or controller 150 operates according to a predetermined scheme without the use of sensors.

In some embodiments of the invention, air from compressor 140 is directed at inspected items 106 in the form of high speed air jets which aid in releasing vapors from the inspected items, as is now described.

Fig. 2 is a cross-section view of a portion of mantle 104, in accordance with an exemplary embodiment of the invention. The upper side of mantle 104 in Fig. 2 is directed toward the inspected items 106. Mantle 104 optionally comprises a flexible and impervious material, for example a plastic, rubber (e.g., latex, silicon rubber), reinforced fabric or reinforced PVC. Mantle 104 may include a stretchable or non-stretchable material. Optionally, embedded within mantle 104 is a network of suction orifices 202 and conduits 204 which connect to blower 124 through air pipes 122 (Fig. 1B). Orifices 202 are optionally distributed throughout the area of mantle 104 so as to collect samples from different positions around inspected items 106. In some embodiments of the invention, orifices 202 are distributed evenly along the area of mantle 104. Alternatively, more orifices 202 are located toward the center of mantle 104 where they have a greater chance to collect samples from items 106.

In some embodiments of the invention, for simplicity, orifices 202 are constantly open and suction is controlled by blower 124. Alternatively, orifices 202 are controllable such that some of the orifices may be closed while others are open. In some embodiments of the invention, each orifice 202 is controlled separately. Alternatively or additionally, orifices 202 may be controlled in groups. For example, different orifices 202 may be operated at different times according to a parameter of the currently applied vapor release method, for example the angle at which air jets are directed at items 106. Alternatively or additionally, orifices 202 are opened or closed according to the distance between the orifice and inspected items 106. In some embodiments of the invention, orifices 202 which are too close to, or too far from, inspected items 106 are closed, so that the air that they collect, which does not efficiently collect vapor does not dilute air collected through other orifices. Optionally, each orifice 202 (or group of orifices) is associated with a distance sensor which senses the distance between the orifice and inspected items 206. Alternatively or additionally, after removing the air from inspection chamber 104 (reaching the state in Fig. 1B) before applying vapor release methods, the air suction of orifices 202 is tested. Orifices that are inefficient and/or too efficient (they are far from the inspected items) are optionally closed.

A network of jet orifices 206, interconnected by air tubes 208, is optionally also embedded within mantle 104, separate from conduits 204 of suction orifices 202. Jet orifices 206 optionally connect to compressor 140, through air pipes 132. Jet orifices 206 are optionally used to direct air jets at inspected items 106. Orifices 206 are optionally distributed throughout the area of mantle 104 so as to inject air jets toward the inspected items from different positions around inspected items 106. In some embodiments of the invention, orifices 206 are distributed evenly along the area of mantle 104. Alternatively, more orifices 206 are located toward the center of mantle 104 where they have a greater chance to dislodge samples from items 106. In some embodiments of the invention, the distribution of orifices 202 and 206 is similar. Alternatively, suction orifices 202 are distributed differently from jet orifices 206. For example, in some embodiments of the invention, suction orifices 202 are intercalated, in order to reduce the tube length through which collected vapors need to pass on their way to collector 126.

In some embodiments of the invention, for simplicity, orifices 206 are constantly open and the air jets are controlled by activating and deactivating compressor 140. Alternatively, orifices 206 are controllable such that some of the orifices may be closed while others are open. Optionally, jet orifices 206 include valves that control the air pressure that comes from compressor 140. In some embodiments of the invention, each orifice 206 is controlled

separately. Alternatively or additionally, orifices 206 may be controlled in groups. For example, different orifices 206 may be operated at different times according to a parameter of the currently applied vapor release method and/or the currently open suction orifices 202. Alternatively or additionally, jet orifices 206 are opened or closed according to the distance
5 between the orifice and inspected items 106, optionally according to any of the methods described above with reference to suction orifices 202.

Alternatively or additionally to embedding conduits 204 and/or 208 within mantle 104, the air tubes may be attached on mantle 104, for example on an inner or outer surface of the mantle. Further alternatively or additionally, one or more air tubes pass through mantle 104 and
10 are not attached to the mantle and/or are substantially perpendicular to the mantle. Optionally, a large number of air tubes enter the mantle, for example, above 20, 50 or even 100. Further alternatively or additionally, air tubes are directed at inspected items 106 from beneath (e.g., are placed on table 130, or beneath the table as described above) or from above. In some embodiments of the invention a separate structure within inspection chamber 136, beneath
15 mantle 104, carries the air tubes. Optionally, this structure also carries other vapor release apparatus, such as one or more heaters.

In some embodiments of the invention, mantle 104 comprises protruding legs 220, which prevent the mantle from closely touching the inspected items 106. Optionally, protruding legs 220 are positioned evenly throughout the area of mantle 104. Alternatively or additionally,
20 protruding legs 220 are positioned with a higher density around suction orifices 202 in order to prevent the mantle from obstructing the flow of air into the suction orifices. In some embodiments of the invention, the length of protruding legs 220 is adjustable, for example according to the maximal dilution allowed in a specific scanning procedure. Alternatively or additionally, during an inspection session, the length of protruding legs 220 is adjusted to
25 different lengths to maximize the suction and/or air jet effects.

Alternatively or additionally to protruding legs 220, the air pressure within chamber 136, relative to the air pressure between external enclosure 102 and mantle 104, prevents the mantle from attaching to inspected items 106. Further alternatively or additionally, a separate construction is used to prevent mantle 104 from touching inspected items 106.

30 As described above, in some embodiments of the invention, air jets are used to enhance vapor release from inspected items 106. Optionally, for simplicity, the air jets are at room temperature. Alternatively, the air jets include relatively hot air which is known to increase vapor release rates. In some embodiments of the invention, compressor 140 streams hot air into

air pipes 132. Alternatively or additionally, one or more heaters heat the air while it passes through air pipes 132. Further alternatively or additionally, as described below, a heater within the chamber defined by mantle 104 heats the air from compressor 140 before it is shot at inspected items 106.

5 The jets are optionally directed at items 106 intermittently in pulses, for example 2-10 pulses per second. In some embodiments of the invention, the pulses are very short and at high pressures, so as to generate shock waves. Optionally, in these embodiments, the tubes providing the jets have a relatively large diameter. Alternatively, the pulses are relatively long, at least a few milliseconds for each pulse, requiring less complex valves. Further alternatively,
10 the jets are constant and not pulsed.

 Optionally, the air provided in the air jets by compressor 140 is cleaned, for example using an active carbon filter and/or a silica media filter, such that dirt and/or vapors are removed from the injected air. The filtering optionally reduces the noise level in trace analyzer 127, even if the dirt in the air is not of the same chemicals as being searched for. Alternatively
15 or additionally, the air provided in the air jets is dried in order to remove water vapors, which may interfere with the operation of trace analyzer 127.

 In some embodiments of the invention, instead of using air to carry vapors from the inspected items 106, a different carrier gas, for example as described in, above mentioned, U.S. patent 6,324,927 is pumped by compressor 104 into the chamber and optionally at the
20 inspected items. The different carrier gas may include a noble gas, such as argon and/or helium and/or may include relatively neutral gases, such as nitrogen and CO₂. Alternatively or additionally, a gas including a solvent, such as isopropyl alcohol and/or acetone vapors, is used, so that the carrier gas enhances the vapor release from inspected items 106. Further alternatively or additionally, a gas that has affinity to explosive materials, such as methyl
25 amine, is used.

 In some embodiments of the invention, jet orifices 206 all provide pulses of the air jets at substantially the same time. Alternatively, air jets from different jet orifices 206 are provided at different times. Optionally, air jets are provided through different jet orifices 206 according to a predetermined sequence, so as to induce a lateral air flow with the inspection chamber.
30 Such a lateral air flow may aid in releasing vapor from the inspected items and/or in transfer of air samples to collector 126. In some embodiments of the invention, suction orifices 202 all suck air from the inspection chamber at the same time. These embodiments allow connection of all of suction orifices 202 through a single conduit 204. Alternatively, suction orifices 202

suck air at different times according to a predetermined scheme (optionally a scheme in common with the control of jet orifices 206), for example in order to induce air flow within the inspection chamber.

Other vapor releasing enhancement methods may be used alternatively or additionally to gas jets. In some embodiments of the invention, several cycles of increasing and decreasing the air pressure are applied within inspection chamber 136. The air pressure within external enclosure 102 is optionally adjusted accordingly so that mantle 104 does not move due to the pressure change. Alternatively or additionally to pressure changes, a high air pressure is formed in chamber 136 in order to force vapors out of the interior of inspected items 106.

In some embodiments of the invention, heaters heat the surface of the inspected item. Alternatively or additionally, light, sound (e.g., ultrasound, low frequency sound) and/or shock waves are directed at inspected items 106. In some embodiments of the invention, vapor release is enhanced by applying mechanical vibration to the inspected items, for example by vibrating table 130. Alternatively or additionally, inspected items 106 are placed within mantle 104 on a vibration unit. Further alternatively or additionally, inspection system 100 is mounted on a vehicle (e.g., ship, truck) which moves during operation so that inspected items 106 are vibrated. Further alternatively or additionally, any other method of inducing vapor release, known in the art, may be used.

Alternatively or additionally to sucking gas samples to a collector unit, trace analyzers and/or collection units are embedded within inspection chamber 136 and/or within the tubes leading gas toward collector 126. Embedded trace analyzers may be attached to mantle 104 on an inner surface, may be placed on table 130, may be hung from above and/or may be placed on a separate structure within mantle 104. Optionally, the embedded trace analyzers are small (having a diameter of about 1 inch and/or a weight of about 20 grams) so that they fit within the tubes (e.g., in a caving), conduits 204 and/or the chamber. Positioning trace analyzers within inspection chamber 136 and/or as close as possible thereto, reduces the distance that the vapors must pass on their way to analysis and hence reduces the chances of settling before reaching collector 126. Optionally, the embedded trace analyzers are connected through wires and/or a wireless connection to a control unit which provides indications to a human in charge of system 100.

In some embodiments of the invention, one or more embedded trace analyzers are used to detect specific chemicals which are hard to detect in collector 126. Alternatively or additionally, one or more embedded trace analyzers are used for additional accuracy beyond

that provided by collector 126. For example, embedded trace analyzers may be of limited accuracy but may detect vapors which have less ability to be sucked through relatively long tubes. Alternatively, the embedded trace analyzers are used instead of collector 126. In some of these alternative embodiments, suction tubes are not used.

5 Fig. 3 is a flowchart of acts performed during an inspection session, in accordance with an exemplary embodiment of the invention. Optionally, a lower enclosure surface is spread out (302) on table 130 or on any other surface. Inspected items 106 are then placed (304) on the lower enclosure surface. Mantle 104 is brought to cover (306) inspected items 106. Mantle 104 is optionally connected (308) to the lower enclosure surface in a manner which prevents air
10 leakage from inspection chamber 136. Thereafter, as described above, air is pumped (310) out of inspection chamber 136 so that the size and air content of the chamber is minimized. Vapor release measures are applied (312) to inspected items 106 and in addition, air is collected (314) from inspection chamber 136.

 Alternatively to forming chamber 136 from mantle 104 and a lower enclosure surface,
15 chamber 136 may be defined by a single piece mantle and/or by a plurality of mantle pieces connected in a different form.

 Figs. 4A-4C schematically illustrate mantle structures, in accordance with exemplary embodiments of the invention. In Fig. 4A, a single-piece mantle 401 is shown. Optionally, inspected items 106 are placed on single-piece mantle 401 while it is spread out flat on a
20 surface. Thereafter, ends 402 of mantle 401 are lifted and connected above inspected items 106, in order to form a sealed chamber.

 In Fig. 4B, inspected items 106 are optionally placed on a table 412. Thereafter, right and left half mantles 410 are connected to each other forming a sealed chamber.

 In Fig. 4C, the chamber is defined by walls, one or more of which are movable. After
25 placement of inspected items 106, the walls of the chamber are moved toward the inspected items in order to limit the volume of the chamber. The side walls are optionally partially collapsible in order to allow the ceiling wall to move down toward inspected items 106.

 Fig. 5 is a schematic illustration of an inspection system 500, in accordance with an exemplary embodiment of the invention. System 500 optionally comprises a fixed casing 502,
30 which defines an inspection chamber 520, in which inspected items 106 are placed, for inspection. In some embodiments of the invention, inspection 520 is sealed in a manner which prevents air from entering or escaping the chamber. Alternatively, the chamber may be operated while it is partially open, for example when it is not desired to seal the inspected

items. One or more air tube structures 504 within inspection chamber 520 have an adjustable position. Air tube structures 504 optionally carry air tubes with suction and/or jet orifices 508 directed toward items 106.

In some embodiments of the invention, air tube structures 504 are mounted on adjustable length arms 510 which control the distance between the structures 504 and items 106. Optionally, after inspected items 106 are placed in chamber 520, structures 504 are automatically brought to a predetermined distance from the inspected items 106. The positions of structures 504 are optionally adjusted so that the distance between orifices 508 and inspected items 106 is optimal for collecting samples. Alternatively or additionally, during an inspection session, structure 504 is positioned at different locations, according to a predetermined operation program. Further alternatively or additionally, the position of structures 504 is adjusted according to inspection of air collected from the surroundings of the inspected items. For example, if in a certain positioning of structure 504 a high dust content or low vapor content is collected, the positioning of structure 504 is changed to achieve better results.

In some embodiments of the invention, a system-testing tracer chemical (identifiable by systems 100 or 500) is placed on the inspected items in order to serve as a testing material for the system. If the testing material is identified with a suitable range, the positioning of structures 504 is considered suitable for detection. Otherwise, the positioning of one or more structures 504 is changed and the test is repeated. Optionally, the tracer chemical is different from the chemicals (e.g., drugs, explosives) searched for, so that the tracer chemical does not interfere with the inspection of the luggage. Alternatively or additionally, the placement of the testing chemical is removed after the positioning of structure 504 is verified, so that the testing chemical does not interfere with detection of the vapors being searched for. Further alternatively or additionally, the testing chemical is used after samples for detection of the vapors searched for are collected, to determine if the results are valid. The tracer chemical may optionally be used for purposes other than adjusting the positioning of structures 504, for example for system development and/or proper operation monitoring.

In some embodiments of the invention, a distance sensor is mounted on structures 504 to measure the distance between the structures and inspected items 106. Alternatively or additionally, structures 504 include protruding legs of a predetermined or adjustable length which aids in defining the distance between the structure 504 and items 106.

In some embodiments of the invention, a heater 530 is mounted on one or more of structures 504 or is otherwise positioned within chamber 520. Optionally, air jets from one or

more orifices 508 are directed at heater 530 which heats the air jets and redirects the air toward inspected items 106. Optionally, the angle of heater 530 may be adjusted to achieve better vapor release results.

The inspection systems of the present invention may be used for substantially any items, including luggage and cargo. The system may be used to search for explosives, drugs, pests, pesticides, toxin contamination in agriculture produce, and/or any other chemical substances which it may be desired to detect. The inspection systems of the present invention may be used in substantially any location, including, for example, airports and entrances to sensitive buildings.

In some embodiments of the invention, in order to enhance the ability to detect vapors from within the inspected items, one or more collection heads are inserted into the inspected items before the inspection session of the items begins. The collection heads may be used to further induce vapor release and/or to provide additional collection orifices from within the inspected items, as is now described.

Fig. 6 is a schematic illustration of a collection head 600, in accordance with an exemplary embodiment of the invention. Collection head 600 optionally includes one or more suction orifices 605, which connect through a suction tube 602 to collector 126 (Fig. 1B) and blower 124. Optionally, suction tube 602 and/or tube 122 only allow flow in one direction, so as to prevent loss of samples in case of decompression of collection head 600, for example due to power failure. In some embodiments of the invention, suction tube 602 and/or tube 122 include one way valves which prevent backflow. Alternatively or additionally, the pressure in collection head 600 and/or in the chambers to which the tubes lead is controlled, so as prevent flow in the incorrect direction.

Alternatively or additionally, collection head 600 includes one or more jet orifices 604, connected through a jet tube 603 to compressor 140. In some embodiments of the invention, one or more valves 610 are used to control the flow to or from one or more specific orifices an/or groups of orifices. Alternatively or additionally, one or more entrance valves 612 at the entrance to collection head 600 control all the jet and/or suction orifices together.

In some embodiments of the invention, air jets from jet orifices 604 are always directed in the same direction. Alternatively, the angle of release of air jets from one or more of jet orifices 604, such that the air jets may be directed in different directions during a single inspection session, without moving collection head 600. For example, jet orifices 604 may be

rotatably mounted on collection head 600, so as to allow changes in the impinging direction of the air jets.

Jet orifices 604 and suction orifices 605 may operate in parallel with respective orifices in mantle 104 (Fig. 2). Alternatively or additionally, the orifices of collection head 600 may operate at complimentary times to the orifices of mantle 104 in accordance with a single session plan. Further alternatively or additionally, the operation of the orifices of collection head 600 is controlled according to a plan independent of any operation plan of the orifices of mantle 104.

Optionally, collection head 600 includes additional and/or alternative vapor release enhancers. For example, collection head 600 may include a heater, a radiation source and/or a vibrator. Optionally, collection head 600 comprises a rigid cassette that does not change its volume. Alternatively, collection head 600 comprises an inflatable pillow, which may be inflated and/or deflated in order to induce vibrations. Further alternatively or additionally, collection head 600 comprises an internal mechanical and/or electrical motor and/or springs which induce vibrations upon command. Further alternatively or additionally, collection head 600 includes other vibration mechanisms, such as a mechanism for inducing vibration by directing gas jets in one or more directions.

In some embodiments of the invention, collection head 600 includes one or more sensors 620, for example, temperature and/or pressure sensors, whose readings are provided to controller 150. Controller 150 optionally controls the operation of collection head 600, setting one or more vapor release and/or collection parameters, according to the readings of the sensors.

In some embodiments of the invention, as described above, collection head 600 operates in conjunction with mantle 104 or system 500. In these embodiments, collection head 600 may be used for both sample collection and enhancement of vapor release or may be used for only one of the tasks, the other task being carried out by mantle 104.

Alternatively or additionally, collection head 600 may be operated alone without mantle 104. For example, an inspection session may include a first stage including placing an inspection item 106 within chamber 136 and collecting gas samples using mantle 104, and a second stage in which samples are collected by collection head 600 inserted into the inspected item. Optionally, during the second stage, a human operator may hold collection head 600 and move it around within the inspected item. In some embodiments of the invention, collection head 600 includes a handle (not shown) for human manipulation of the collection head.

As described above, gas samples from collection head 600 are provided to the same collector 126 as the gas samples from mantle 104. In some embodiments of the invention, however, different collectors may be used for collection head 600 and for mantle 104. The different collectors are optionally connected to the same trace analyzer, which receives samples
5 from the different collectors in parallel or at different times. Alternatively, the different collectors are connected to different trace analyzers, which test for the same chemicals or for different chemicals.

In some embodiments of the invention, collection head 600 serves as a dual purpose apparatus which may be used both for item inspection as described above and for inspection of
10 people. Optionally, when used to inspect people, an operator hold collection head 600 and passes it around the inspected person. In some embodiments of the invention, when used to inspect people, when or more operation parameters of collection head 600 are adjusted accordingly, for example, the heat of the air jets (so as not to cause discomfort to the inspected person) and/or the direction of the air jets (toward the inspected person). Optionally, collection
15 head 600 has a plurality of operation modes. For example, a first operation mode is used for inspecting items where collection head 600 is within the item and is substantially surrounded by the item. In the first operation mode, air jets are optionally transmitted in all directions (according to the distribution of orifices). In a second operation mode, collection head 600 is used to inspect a person. In the second operation mode, air jets are directed only in a single
20 direction.

In some embodiments of the invention, collection head 600 includes apparatus other than required for gas sample collection. For example, collection head 600 may include a metal detector. The metal detector may be operated during the second operation mode when used to inspect persons.

Fig. 7 is a schematic illustration of a self contained vapor collection unit 700, in
25 accordance with an exemplary embodiment of the invention. Collection unit 700 is optionally similar to collection head 600, but is self contained and is not connected through air tubes to an external system. Collection unit 700 optionally includes a collector 702, a trace analyzer 704 and a blower 708 which sucks samples through suction orifices 605 into collector 702.
30 Alternatively, for example in order to reduce the size of collection unit 700, trace analyzer 704 is not included in the collection unit. Instead, collection unit 700 is connected after a collection session to an external trace analyzer (not shown) or collector 702 is removed from collection unit 700 and connected to an external trace analyzer. Optionally, collection unit 700 includes a

gas tank 706 which contains gas in high pressure, and serves as a source for gas jets. Alternatively or additionally, blower 708 (or a separate compressor) is used to generate gas jets from gas external to collection unit 700. It is noted that additional vapor release apparatus, for example any of those described above with relation to collection head 600, may also be included in collection unit 700.

A battery 710 optionally provides power for operation of collection unit 700. Alternatively, collection unit 700 is connected to an external power line. An internal controller 712 optionally controls the operation of collection unit 700 according to pre-programmed instructions. Alternatively or additionally, internal controller 712 is connected through wires or wirelessly to an external controller.

Collection unit 700 is optionally placed in an inspected item for an inspection procedure. In some embodiments of the invention, collection unit 700 is used alone and not in conjunction with system 100 or system 500 described above. For example, in transferring mail or cargo, one or more collection units 700 are placed in the mail bag or cargo casing before the transfer and is removed after the transfer. When the collection unit 700 is removed from the cargo casing, its contents are checked for chemicals being searched for. Alternatively or additionally, an alarm signal may be wirelessly transmitted to a control station if a chemical of interest is found within the inspected item. Optionally, the jogging of the cargo and/or the long term placement of unit 700 with the cargo is relied upon to release vapors from the cargo, such that the amount of enhancement vapor release measures applied by collection unit 700 may be reduced or not used at all. Alternatively or additionally, collection unit 700 may be used for short periods. For example, collection unit 700 may be inserted to the inspected item, operated, and then immediately removed and connected to a trace analyzer. Optionally, in parallel to connecting collection unit 700 to the external trace analyzer, battery 710 is charged such that there is sufficient power to perform additional collection sessions. Alternatively or additionally, between collection sessions, collection unit 700 is cleaned.

In some embodiments of the invention, for example for inspecting large inspected items, a plurality of collection units are inserted into the inspected item.

Collection unit 700 may operate continuously until it is removed from the inspected items or until its power source is drained out. Alternatively, collection unit 700 operates according to a pre-configured operation program stored in controller 712. Further alternatively or additionally, collection unit 700 operates according to commands transmitted from an

external unit with which it operates in coordination. For example, collection unit 710 may operate in coordination with system 100 described above.

Collection unit 700, as shown, includes both vapor collection means and vapor release enhancement means. In some embodiments of the invention, however, a collection unit which only collects vapors and does not induce vapor release may be used. Such a collection unit may be lighter, cheaper and smaller. Alternatively or additionally, a vapor release enhancement unit which does not collect vapors is used.

In some embodiments of the invention, both a vapor release collection means and a vapor release enhancement unit are placed within the inspected item, together and/or at different places or ends in the inspected item. Alternatively or additionally, for example in use with system 100, only a vapor collection unit or only a vapor enhancement unit, may be used. As described above, a collection unit may be used on its own and, for example, the transport of the inspected items may be used to induce vapor release.

In an exemplary embodiment of the invention, after inserting a collection unit to the inspected item, the inspected item is inserted into chamber 136 in order to induce vapor release. In other embodiments of the invention, a vapor release unit is inserted into the inspected item for operation while the inspected item is within chamber 136.

It will be appreciated that the above described methods may be varied in many ways, including, changing the order of steps, and/or performing a plurality of steps concurrently. It should also be appreciated that the above described description of methods and apparatus are to be interpreted as including apparatus for carrying out the methods, and methods of using the apparatus. The present invention has been described using non-limiting detailed descriptions of embodiments thereof that are provided by way of example and are not intended to limit the scope of the invention. It should be understood that features and/or steps described with respect to one embodiment may be used with other embodiments and that not all embodiments of the invention have all of the features and/or steps shown in a particular figure or described with respect to one of the embodiments. Variations of embodiments described will occur to persons of the art. Furthermore, the terms "comprise," "include," "have" and their conjugates, shall mean, when used in the claims, "including but not necessarily limited to."

It is noted that some of the above described embodiments may describe the best mode contemplated by the inventors and therefore may include structure, acts or details of structures and acts that may not be essential to the invention and which are described as examples. Structure and acts described herein are replaceable by equivalents which perform the same

function, even if the structure or acts are different, as known in the art. Therefore, the scope of the invention is limited only by the elements and limitations as used in the claims.

CLAIMS

1. A method of collecting vapors from an inspected item, comprising:

providing an item for inspection;

5 forming a chamber around the inspected item, with a volume determined responsive to the inspected item;

applying one or more vapor release measures to the dimensions of the inspected item;

removing gas samples from the formed chamber; and

analyzing the removed gas samples for traces of one or more chemicals.

10

2. A method according to claim 1, wherein providing the item for inspection comprises placing the item in a chamber and wherein forming the chamber around the inspected item comprises reducing the volume of the chamber.

15 3. A method according to claim 2, wherein reducing the volume of the chamber comprises pumping air out of the chamber.

4. A method according to claim 2, wherein pumping air out of the chamber comprises pumping using a same blower as used for removing gas samples from the inspected items.

20

5. A method according to claim 4, wherein the chamber is at least partially defined by a flexible mantle, which conforms to the dimensions of the inspected items when the air is pumped out of the chamber.

25 6. A method according to claim 5, wherein after the air is pumped out of the chamber the mantle is spaced from the objects by legs protruding from the mantle.

7. A method according to claim 2, wherein reducing the volume of the chamber comprises moving one or more walls of the chamber toward the inspected item.

30

8. A method according to claim 1, wherein forming the chamber comprises forming an air tight chamber.

9. A method according to claim 8, wherein forming the chamber comprises forming a chamber having an pressure lower than its surrounding.

10. A method according to claim 1, wherein providing the item for inspection comprises placing the inspected item on a flexible mantle and wherein forming a chamber around the inspected item comprises connecting portions of the mantle on different sides of the inspected item.

11. A method according to claim 1, wherein forming the chamber around the inspected item comprises connecting a plurality of walls around the provided item, so as to form the inspected chamber.

12. A method according to claim 1, wherein forming the chamber around the inspected item comprises rapping a single mantle around the inspected item.

13. A method according to claim 1, wherein forming the chamber comprises forming a chamber having a volume of 20% or less larger than the volume of the inspected item.

14. A method according to claim 1, wherein applying one or more vapor release measures to the inspected item comprises applying one or more gas jets to the inspected item.

15. A method according to claim 14, wherein applying the one or more gas jets and removing the gas samples are controlled together so that the pressure of the chamber follows a desired course.

16. A method according to claim 15, wherein the chamber formed around the inspected item is located within an external chamber and wherein the control of the applied gas jets and the removing of the samples is performed such that relative pressure between the chamber formed around the inspected item and the external chamber is substantially constant.

17. A method according to claim 14, wherein forming the chamber around the inspected item comprises forming the chamber such that at least one wall of the chamber, carrying an

orifice applying a gas jet at the inspected item is within a predetermined distance range from the inspected item.

18. A method according to claim 14, wherein applying one or more air jets at the inspected
5 item comprises applying hot air jets at the item.

19. A method according to claim 14, wherein applying one or more air jets at the inspected
item comprises applying intermittent air jets at the item.

10 20. A method according to claim 1, wherein removing gas samples from the formed
chamber comprises exhausting through one or more orifices in at least one wall of the chamber.

21. A method according to claim 1, wherein applying one or more vapor release measures
to the inspected item comprises vibrating the inspected item.

15

22. A method according to claim 1, wherein applying one or more vapor release measures
to the inspected item comprises applying shock waves.

23. A method according to claim 1, wherein removing gas samples comprises removing air.

20

24. A method according to claim 1, wherein removing gas samples comprises removing a
gas other than air.

25. A vapor collection system, comprising:

25

a base on which inspected items are placed;

one or more wall portions adapted to form a chamber of a variable volume around items
placed on the base;

at least one tube adapted to remove gas samples from the chamber; and

an analysis unit adapted to determine whether the gas samples include one or more

30

chemicals.

26. A system according to claim 25, wherein the base and one or more wall portions
comprise a single flexible mantle piece.

27. A system according to claim 25, wherein the one or more wall portions comprise one or more flexible mantle pieces.

5 28. A system according to claim 25, wherein at least a portion of the at least one tube adapted to remove gas samples is coupled to the one or more flexible mantle pieces.

29. A system according to claim 28, wherein at least a portion of the at least one tube adapted to remove gas samples is embedded within the one or more flexible mantle pieces.

10 30. A system according to claim 25, comprising one or more legs protruding from the one or more flexible mantle pieces, which prevent the flexible mantle from closely contacting the inspected items.

15 31. A system according to claim 25, wherein the base participates in defining the chamber with the one or more walls.

32. A system according to claim 25, wherein the base does not participate in defining the chamber with the one or more walls.

20 33. A system according to claim 25, wherein the at least one tubes are embedded within the one or more walls.

34. A system according to claim 25, comprising a blower adapted to exhaust gas out of the
25 chamber so as to adjust the volume of the chamber.

35. A system according to claim 34, wherein the blower is adapted to remove gas samples from the chamber through the at least one tube.

30 36. A system according to claim 34, comprising a compressor adapted to inject gas into the chamber.

37. A system according to claim 36, comprising a controller adapted to control the compressor and the blower such that during a sample collection period of the system, the relative gas pressure between the chamber and the environment around the chamber is substantially constant, while the blower provides gas samples from the chamber to the analysis unit.

38. A vapor collection system, comprising:
one or more wall portions adapted to define a chamber for inspected items;
at least one vapor collection aiding unit; and
a mount having an adjustable position, on which the at least one vapor collection aiding unit is mounted.

39. A system according to claim 38, wherein the at least one vapor collection aiding unit comprises a suction nozzle.

40. A system according to claim 38, wherein the at least one vapor collection aiding unit comprises a unit for inducing vapor release.

41. A system according to claim 40, wherein the unit for inducing vapor release comprises a gas blowing nozzle.

42. A system according to claim 40, wherein the unit for inducing vapor release comprises a heater.

43. A system according to claim 38, wherein the mount is one or more of the wall portions.

44. A system according to claim 38, wherein the mount is separate from the wall portions.

45. A system according to claim 38, wherein the position of the mount is adjusted by adjusting the air pressure in the chamber.

46. A method of collecting vapors from an inspected item, comprising:

placing a collection head inside the inspected item, the collection head not being held by a human operator;

removing gas samples from the inspected item through the collection head; and
analyzing the removed gas samples to determine if they include one or more chemicals.

5

47. A method according to claim 46, wherein placing the collection head in the inspected item comprises placing a collection head not connected through tubes to an external system.

10

48. A method according to claim 46, wherein placing the collection head in the inspected item comprises placing a collection head connected through tubes to an external system.

49. A method according to claim 46, comprising closing the inspected item with the collection head in the inspected item.

15

50. A method according to claim 46, comprising applying one or more vapor release measures to the inspected item substantially concurrently with removing the gas samples.

20

51. A method according to claim 50, wherein applying one or more vapor release measures to the inspected item comprises applying the one or more release measures from the collection head.

25

52. A method according to claim 50, wherein applying one or more vapor release measures to the inspected item comprises applying the one or more release measures from a unit within the inspected item, separate from the collection head.

53. A method according to claim 50, wherein applying one or more vapor release measures to the inspected item comprises applying the one or more release measures from apparatus external to the inspected item.

30

54. A method according to claim 50, wherein applying one or more vapor release measures to the inspected item comprises directing air jets at the inspected item.

55. A method according to claim 50, wherein applying one or more vapor release measures to the inspected item comprises vibrating the collection head in order to vibrate the inspected item.

5 56. A method according to claim 55, wherein applying one or more vapor release measures to the inspected item comprises inflating and deflating a flexible container of the collection head in order to vibrate the inspected item.

10 57. A method according to claim 56, comprising collecting gas samples from the inspected item by apparatus external to the inspected item, substantially concurrently with collecting the gas samples through the collection head.

58. A method of collecting vapors from an inspected item, comprising:
placing an internal vapor unit inside the inspected item;
15 placing an external vapor unit outside of the inspected item;
applying a vapor release means at the inspected item from a first one of the external and internal vapor units; and
removing gas samples from the inspected item through a second one of the external and internal vapor units.

20

59. A method according to claim 58, wherein the first one of the vapor units comprises the external unit.

25 60. A method according to claim 59, wherein gas samples are not collected from outside the inspected item.

61. A method according to claim 58, wherein the first one of the vapor units comprises the internal unit.

30 62. A method according to claim 61, wherein gas samples are not collected from within the inspected item.

63. A method according to claim 58, comprising additionally applying vapor release means from the second of the external and internal vapor units.

64. A method according to claim 58, comprising additionally removing gas samples from the first of the external and internal vapor units.

65. A method according to claim 58, wherein placing the external vapor unit outside of the inspected item comprises placing the inspected item inside a chamber of the external vapor unit.

66. A method according to claim 58, wherein placing the external vapor unit outside of the inspected item comprises forming a chamber of the external vapor unit around the inspected item.

67. A method according to claim 58, wherein the internal vapor unit is connected through gas pipes to the external unit.

68. A method according to claim 58, wherein the external and internal vapor units are commonly controlled by a single controller.

69. A method according to claim 58, wherein the external and internal vapor units are not commonly controlled during their operation.

70. A method according to claim 58, wherein applying vapor release means comprises directing a gas jet at the inspected item.

71. A method according to claim 70, wherein directing a gas jet at the inspected item comprises directing a jet of purified air.

72. A method according to claim 70, wherein directing a gas jet at the inspected item comprises directing a pulsed jet of gas.

73. A method of collecting vapors from an inspected item, comprising:

inserting a vapor release inducing object into the inspected item;
vibrating the vapor release inducing object; and
collecting gas samples from the inspected object.

5 74. A method according to claim 73, wherein vibrating the vapor release inducing object comprises inflating and deflating a flexible encasement of the vapor release inducing object.

75. A method according to claim 73, wherein vibrating the vapor release inducing object comprises operating a vibrating motor within the vapor release inducing object.

10

76. A method according to claim 73, wherein collecting gas samples comprises collecting from within the inspected item.

77. A method according to claim 73, wherein collecting gas samples comprises collecting
15 from outside of the inspected item.

1/9

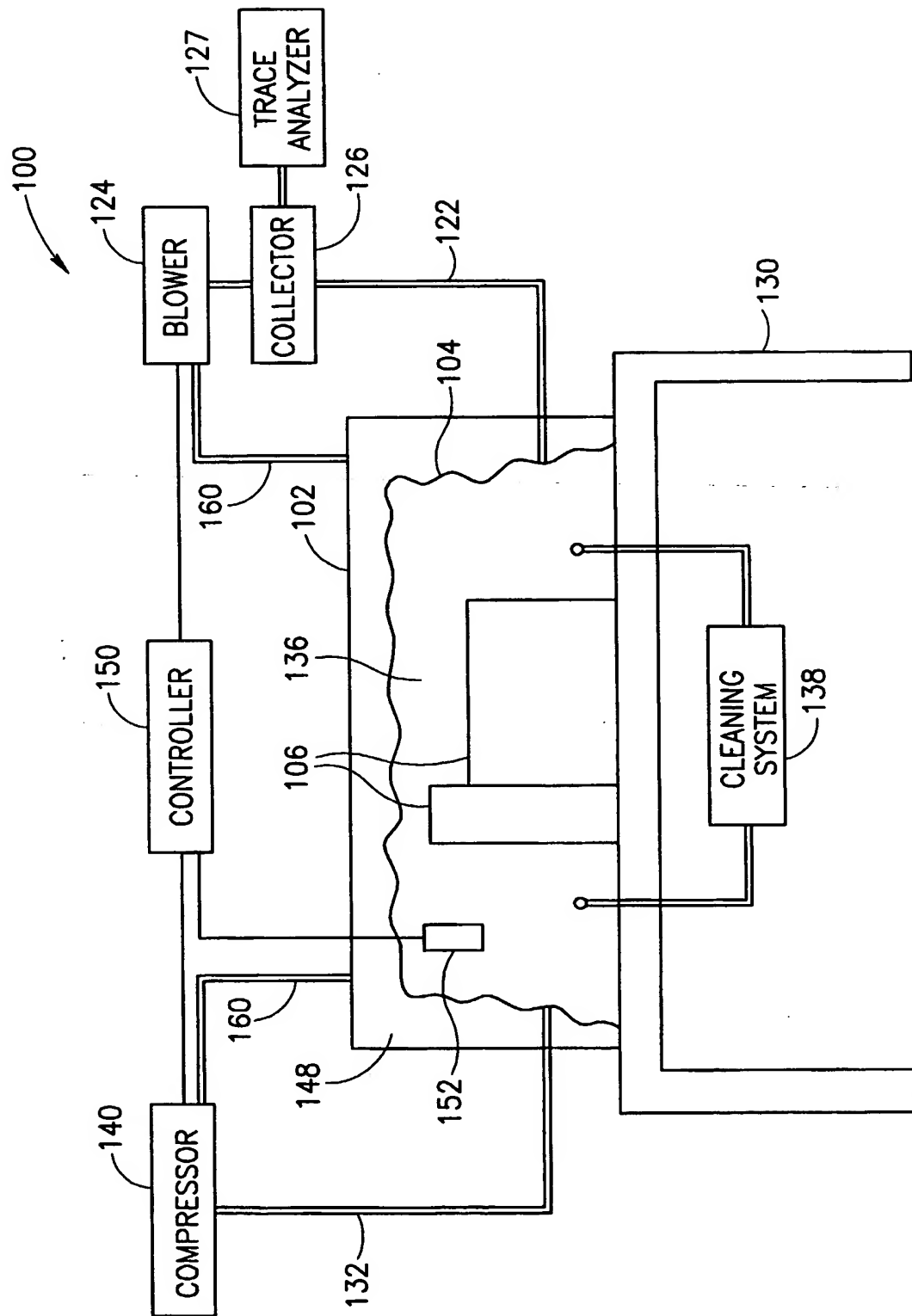


FIG.1A

2/9

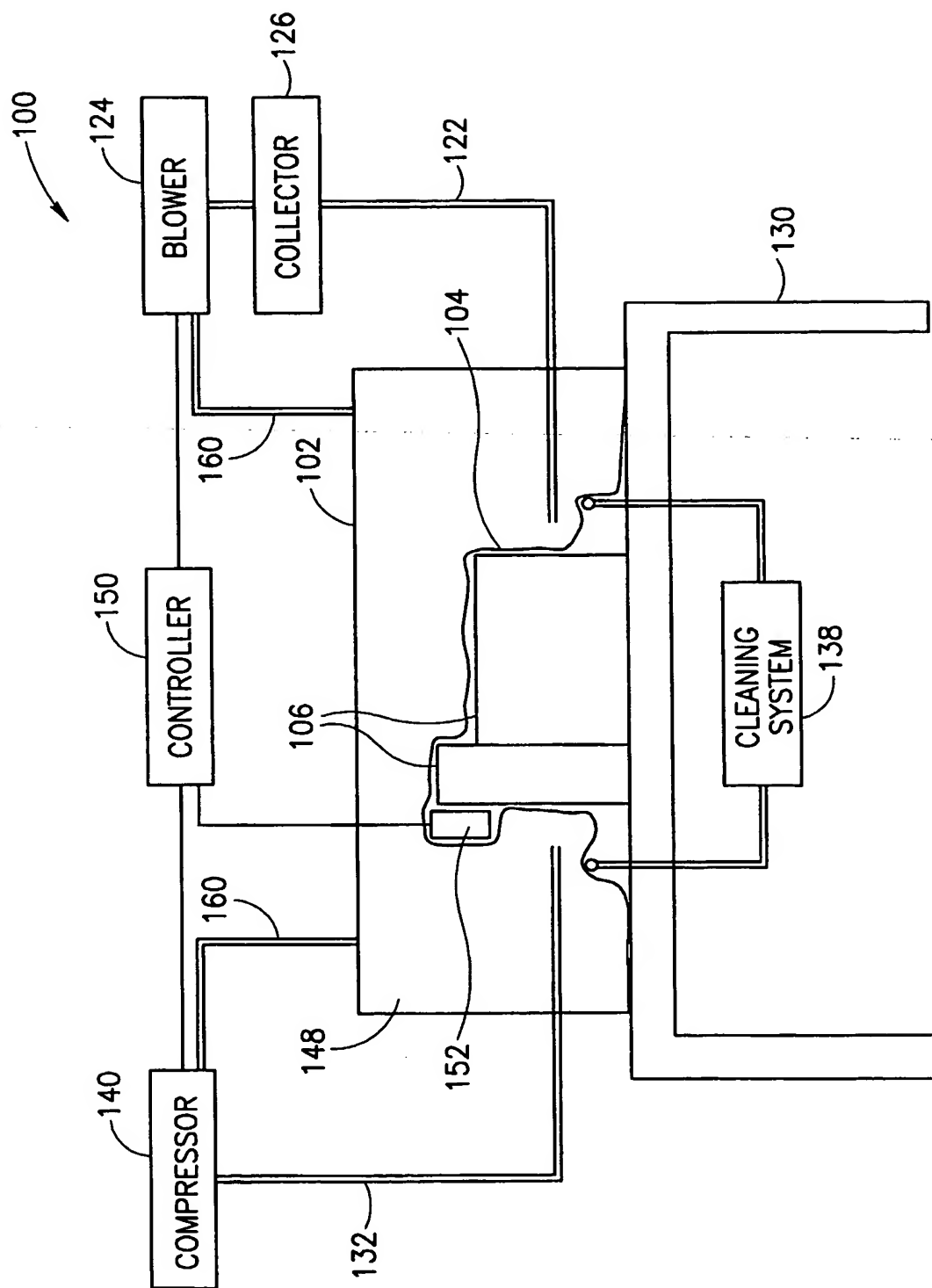


FIG.1B

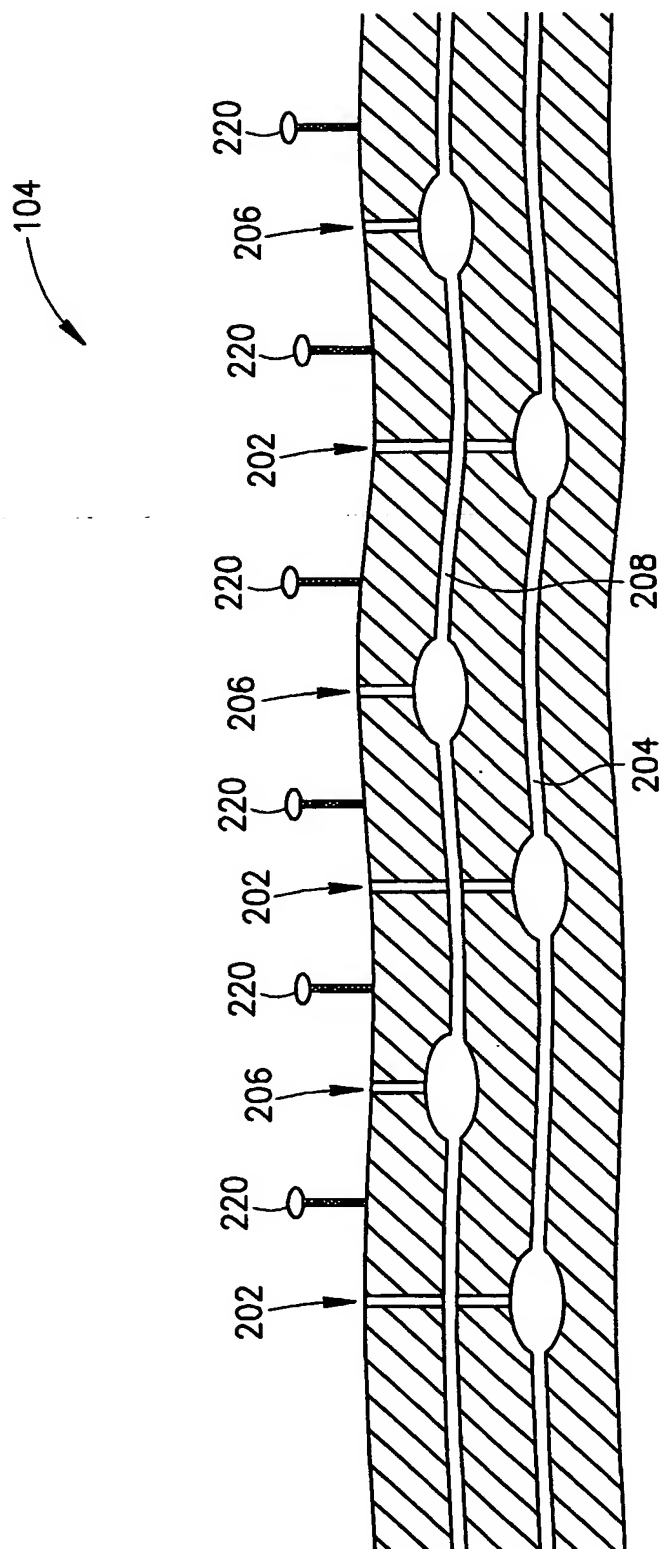


FIG. 2

4/9

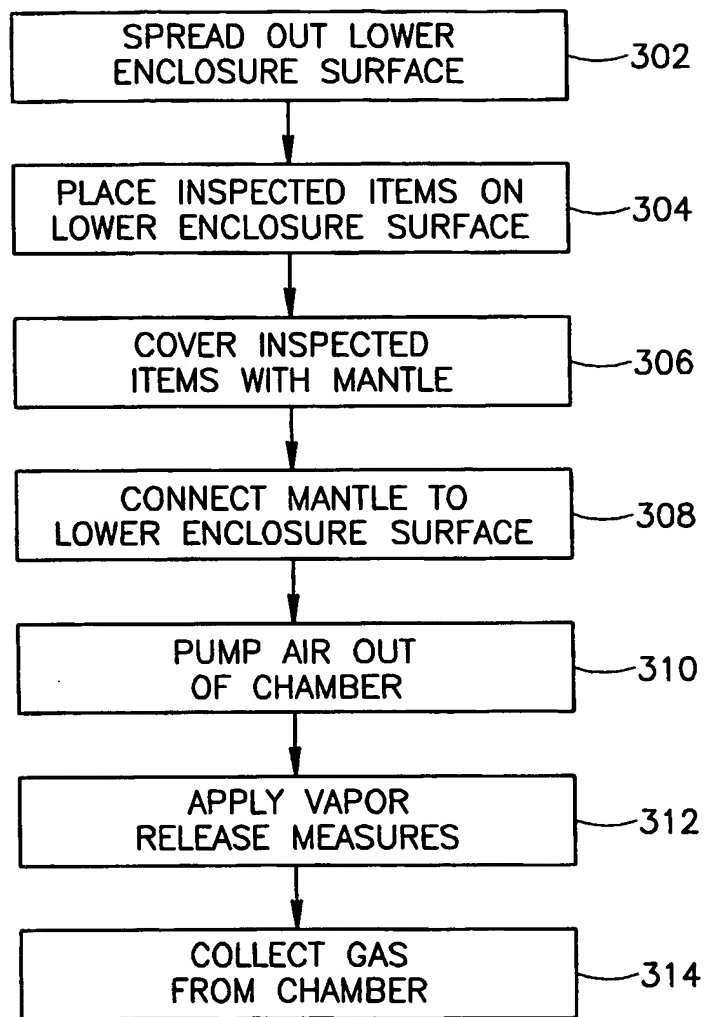


FIG.3

INTERNATIONAL SEARCH REPORT

International application No.

PCT/IL03/00041

A. CLASSIFICATION OF SUBJECT MATTER

IPC(7) : G01N 1/24

US CL : 422/83; 436/177

According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

U.S. : 422/39,63,83,292,294,295; 436/43,55-57,103-104,106,110-111,139,156,177,816,901; 73/863.21

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category *	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
X	US 3,998,101 A (BRADSHAW et al) 21 December 1976, see the abstract and figure 2	1-4,7-33,38-55,58-73 and 75-77
X	US 5,942,699 A (ORNATH et al) 24 August 1999, see the abstract	1,8,9,11-12,14-25,31-33, 38-55,58-73,75-77
---		-----
Y		2-4,7,10,13,26-30

☐

Further documents are listed in the continuation of Box C.

☐

See patent family annex.

* Special categories of cited documents:	
"A" document defining the general state of the art which is not considered to be of particular relevance	"T" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
"E" earlier application or patent published on or after the international filing date	"X" document of particular relevance; the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
"L" document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)	"Y" document of particular relevance; the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art
"O" document referring to an oral disclosure, use, exhibition or other means	"&" document member of the same patent family
"P" document published prior to the international filing date but later than the priority date claimed	

Date of the actual completion of the international search

06 June 2003 (06.06.2003)

Date of mailing of the international search report

07 JUL 2003

Name and mailing address of the ISA/US

Mail Stop PCT, Attn: ISA/US
Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

Facsimile No. (703)305-3230

Authorized officer

Jill Warden

Telephone No. 703-308-0651

5/9

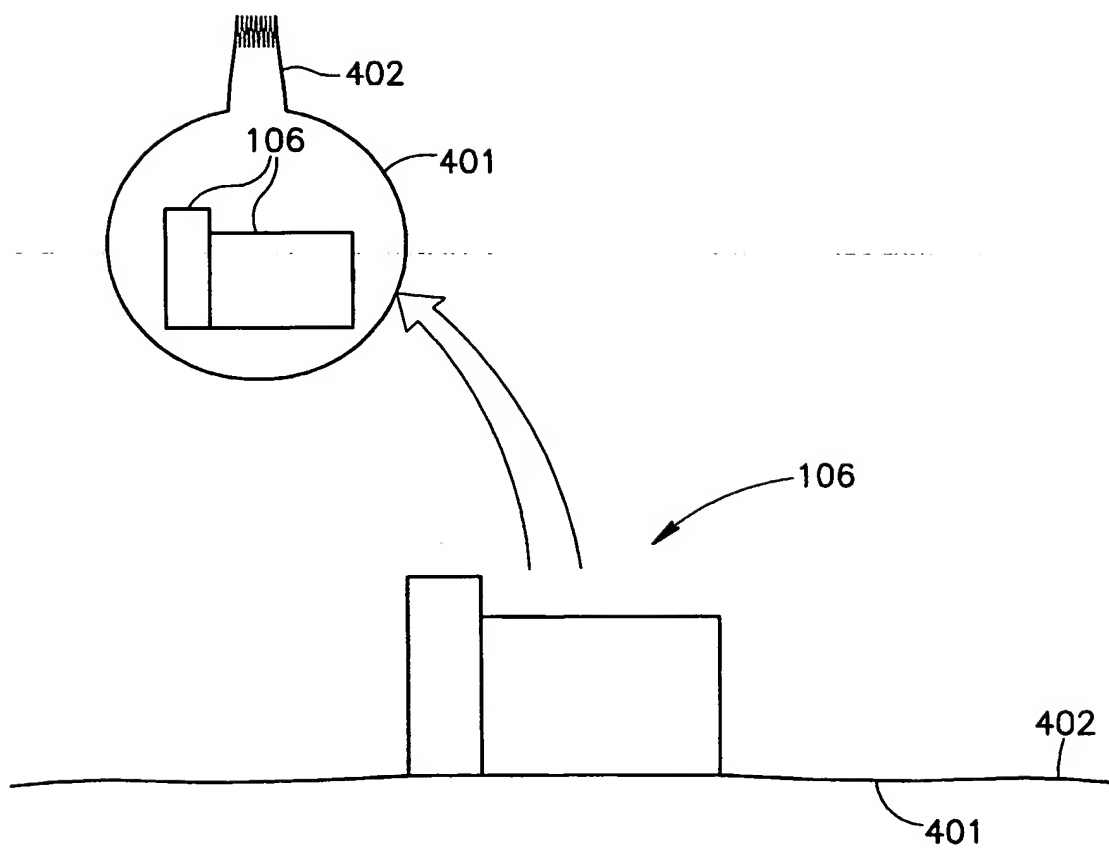


FIG. 4A

6/9

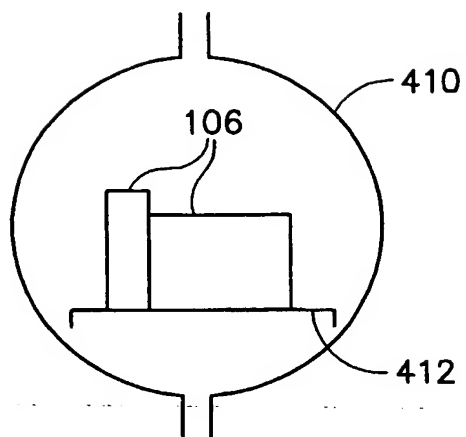


FIG. 4B

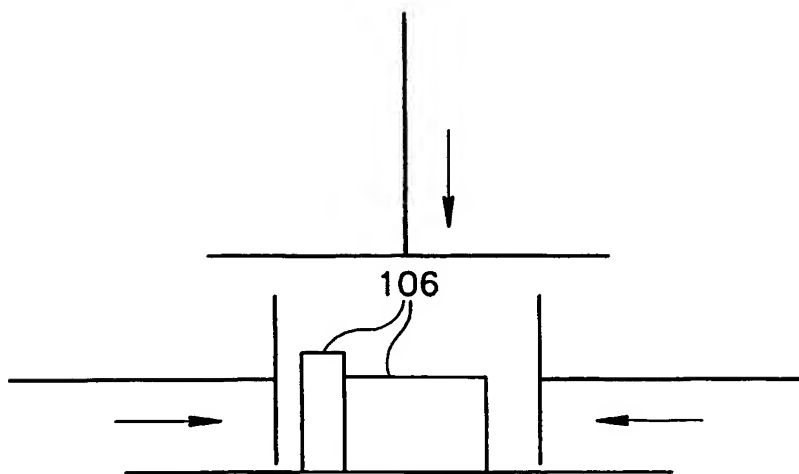


FIG. 4C

8/9

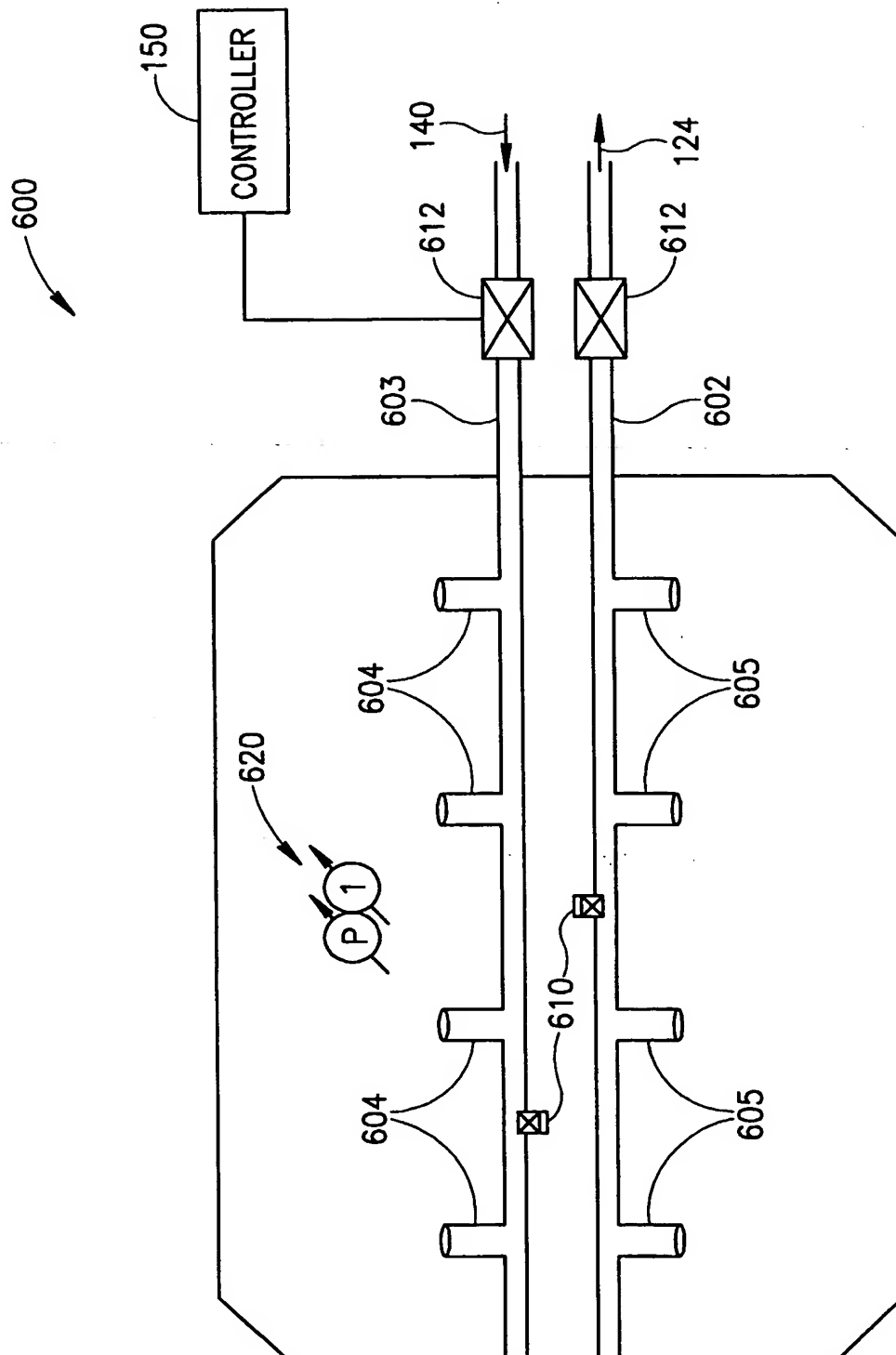


FIG.6

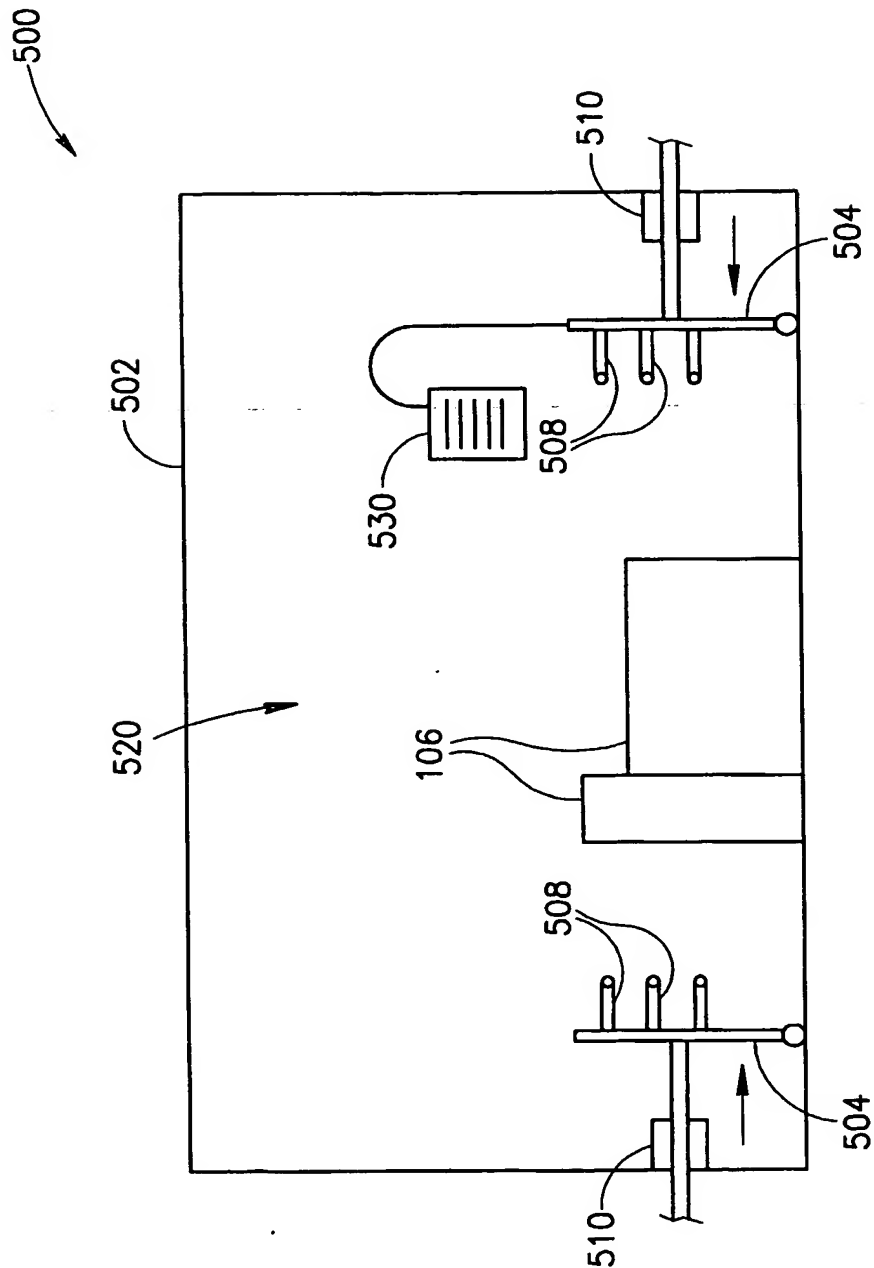


FIG.5

700

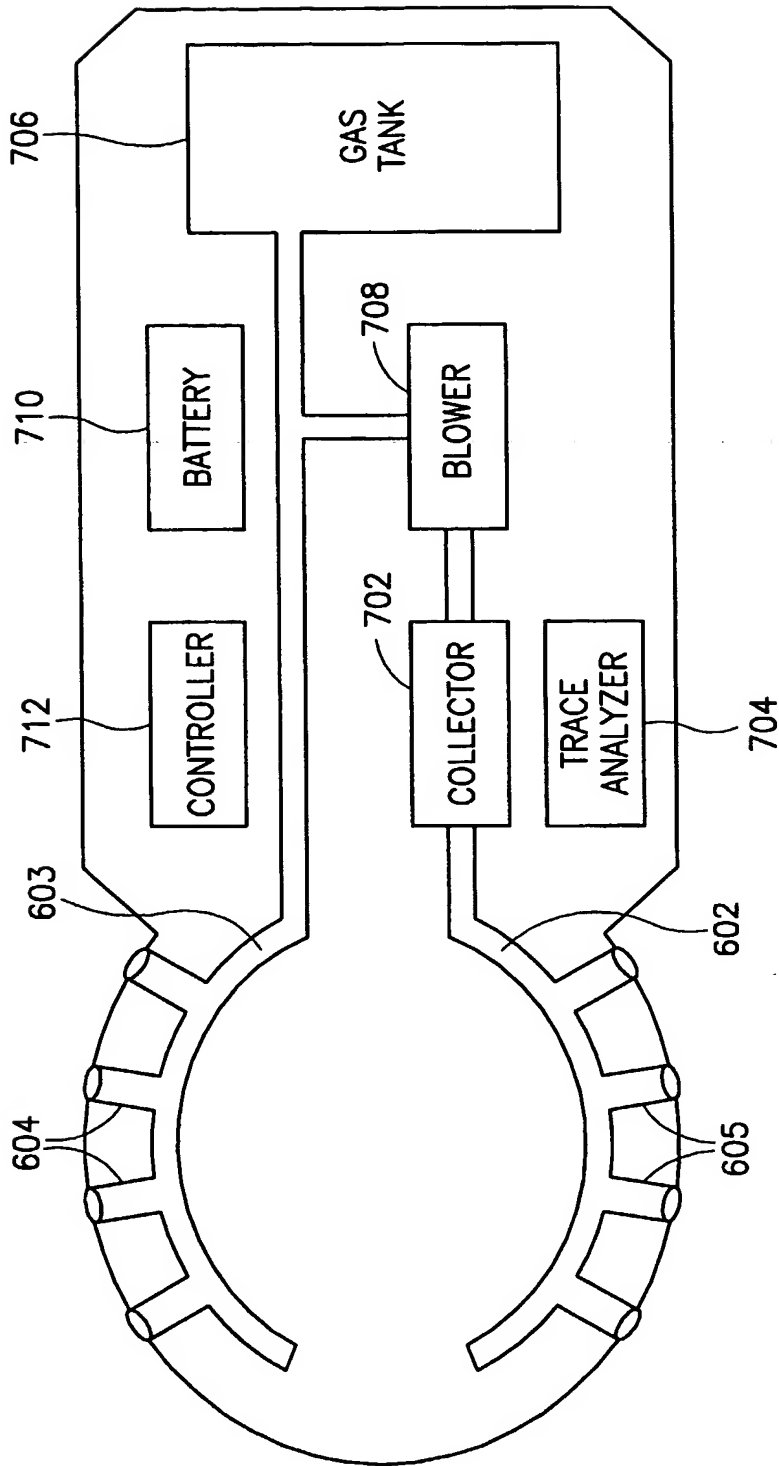


FIG. 7